

CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

Absolute Maximum Ratings, $T_j = 25^\circ\text{C}$ unless otherwise specified

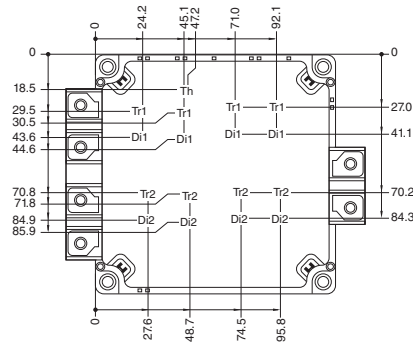
Characteristics	Symbol	Rating	Units
Collector-Emitter Voltage ($V_{GE} = 0V$)	V_{CES}	1700	Volts
Gate-Emitter Voltage ($V_{CE} = 0V$)	V_{GES}	± 20	Volts
Collector Current (DC, $T_C = 125^\circ\text{C}$) ^{*2,*4}	I_C	600	Amperes
Collector Current (Pulse, Repetitive) ^{*3}	I_{CRM}	1200	Amperes
Total Power Dissipation ($T_C = 25^\circ\text{C}$) ^{*2,*4}	P_{tot}	5760	Watts
Emitter Current ^{*2}	I_E^{*1}	600	Amperes
Emitter Current (Pulse, Repetitive) ^{*3}	I_{ERM}^{*1}	1200	Amperes
Isolation Voltage (Terminals to Baseplate, RMS, $f = 60\text{Hz}$, AC 1 minute)	V_{ISO}	4000	Volts
Maximum Junction Temperature, Instantaneous Event (Overload)	$T_{j(max)}$	175	$^\circ\text{C}$
Maximum Case Temperature ^{*4}	$T_{C(max)}$	125	$^\circ\text{C}$
Operating Junction Temperature, Continuous Operation (Under switching)	$T_{j(op)}$	-40 to +150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-40 to +125	$^\circ\text{C}$

*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDi).

*2 Junction temperature (T_j) should not increase beyond maximum junction temperature ($T_{j(max)}$) rating.

*3 Pulse width and repetition rate should be such that device junction temperature (T_j) does not exceed $T_{j(max)}$ rating.

*4 Case temperature (T_C) and heatsink temperature (T_s) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. Refer to the figure to the right for chip location. The heatsink thermal resistance should be measured just under the chips.



Tr1 / Tr2: IGBT, Di1 / Di2: FWDi, Th: NTC Thermistor
 Each mark points to the center position of each chip.

CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

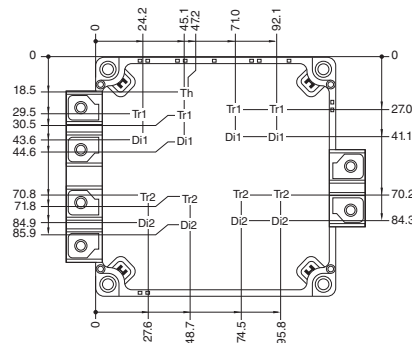
Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Collector-Emitter Cutoff Current	I_{CES}	$V_{CE} = V_{CES}, V_{GE} = 0V$	—	—	1.0	mA
Gate-Emitter Leakage Current	I_{GES}	$V_{GE} = V_{GES}, V_{CE} = 0V$	—	—	0.5	μA
Gate-Emitter Threshold Voltage	$V_{GE(th)}$	$I_C = 60\text{mA}, V_{CE} = 10V$	5.4	6.0	6.6	Volts
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$ (Terminal)	$I_C = 600\text{A}, V_{GE} = 15V, T_j = 25^\circ\text{C}^5$	—	2.0	2.5	Volts
		$I_C = 600\text{A}, V_{GE} = 15V, T_j = 125^\circ\text{C}^5$	—	2.2	—	Volts
		$I_C = 600\text{A}, V_{GE} = 15V, T_j = 150^\circ\text{C}^5$	—	2.25	—	Volts
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$ (Chip)	$I_C = 600\text{A}, V_{GE} = 15V, T_j = 25^\circ\text{C}^5$	—	1.9	2.4	Volts
		$I_C = 600\text{A}, V_{GE} = 15V, T_j = 125^\circ\text{C}^5$	—	2.1	—	Volts
		$I_C = 600\text{A}, V_{GE} = 15V, T_j = 150^\circ\text{C}^5$	—	2.15	—	Volts
Input Capacitance	C_{ies}		—	—	158	nF
Output Capacitance	C_{oes}	$V_{CE} = 10V, V_{GE} = 0V$	—	—	13	nF
Reverse Transfer Capacitance	C_{res}		—	—	2.9	nF
Gate Charge	Q_G	$V_{CC} = 1000V, I_C = 600\text{A}, V_{GE} = 15V$	—	3310	—	nC
Turn-on Delay Time	$t_{d(on)}$		—	—	900	ns
Rise Time	t_r	$V_{CC} = 1000V, I_C = 600\text{A}, V_{GE} = \pm 15V,$	—	—	150	ns
Turn-off Delay Time	$t_{d(off)}$	$R_G = 0\Omega, \text{ Inductive Load}$	—	—	900	ns
Fall Time	t_f		—	—	400	ns
Emitter-Collector Voltage	V_{EC}^{*1} (Terminal)	$I_E = 600\text{A}, V_{GE} = 0V, T_j = 25^\circ\text{C}^5$	—	4.1	5.3	Volts
		$I_E = 600\text{A}, V_{GE} = 0V, T_j = 125^\circ\text{C}^5$	—	2.9	—	Volts
		$I_E = 600\text{A}, V_{GE} = 0V, T_j = 150^\circ\text{C}^5$	—	2.7	—	Volts
Emitter-Collector Voltage	V_{EC}^{*1} (Chip)	$I_E = 600\text{A}, V_{GE} = 0V, T_j = 25^\circ\text{C}^5$	—	4.0	5.2	Volts
		$I_E = 600\text{A}, V_{GE} = 0V, T_j = 125^\circ\text{C}^5$	—	2.8	—	Volts
		$I_E = 600\text{A}, V_{GE} = 0V, T_j = 150^\circ\text{C}^5$	—	2.6	—	Volts
Reverse Recovery Time	t_{rr}^{*1}	$V_{CC} = 1000V, I_E = 600\text{A}, V_{GE} = \pm 15V$	—	—	300	ns
Reverse Recovery Charge	Q_{rr}^{*1}	$R_G = 0\Omega, \text{ Inductive Load}$	—	23	—	μC
Turn-on Switching Energy per Pulse	E_{on}	$V_{CC} = 1000V, I_C = I_E = 600\text{A}, V_{GE} = \pm 15V$	—	167	—	mJ
Turn-off Switching Energy per Pulse	E_{off}	$R_G = 0\Omega, T_j = 150^\circ\text{C}$	—	168	—	mJ
Reverse Recovery Energy per Pulse	E_{rr}^{*1}	Inductive Load	—	106	—	mJ
Internal Lead Resistance	$R_{CC}^{*1} + EE^{*1}$	Main Terminals-Chip, Per Switch, $T_C = 25^\circ\text{C}^4$	—	—	0.6	m Ω
Internal Gate Resistance	r_g	Per Switch	—	2.4	—	Ω

*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDI).

*4 Case temperature (T_C) and heatsink temperature (T_s) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. Refer to the figure to the right for chip location. The heatsink thermal resistance should be measured just under the chips.

*5 Pulse width and repetition rate should be such as to cause negligible temperature rise.



Tr1 / Tr2: IGBT, Di1 / Di2: FWDI, Th: NTC Thermistor
 Each mark points to the center position of each chip.

CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified (continued)

NTC Thermistor Part

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Zero Power Resistance	R_{25}	$T_C = 25^\circ\text{C}^{*4}$	4.85	5.00	5.15	k Ω
Deviation of Resistance	$\Delta R/R$	$T_C = 100^\circ\text{C}$, $R_{100} = 493\Omega^{*4}$	-7.3	—	+7.8	%
B Constant	$B_{(25/50)}$	Approximate by Equation ^{*6}	—	3375	—	K
Power Dissipation	P_{25}	$T_C = 25^\circ\text{C}^{*4}$	—	—	10	mW

Thermal Resistance Characteristics

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance, Junction to Case	$R_{th(j-c)Q}$	Per Inverter IGBT ^{*4}	—	—	26	K/kW
Thermal Resistance, Junction to Case	$R_{th(j-c)D}$	Per Inverter FWDi ^{*4}	—	—	39	K/kW
Contact Thermal Resistance, Case to Heatsink	$R_{th(c-f)}$	Thermal Grease Applied, Per 1 Module ^{*4,*7}	—	7	—	K/kW

Mechanical Characteristics

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Mounting Torque	M_t	Main Terminals, M6 Screw	31	35	40	in-lb
	M_s	Mounting to Heatsink, M5 Screw	22	27	31	in-lb
Creepage Distance	d_s	Terminal to Terminal	22.5	—	—	mm
		Terminal to Baseplate	16.8	—	—	mm
Clearance	d_a	Terminal to Terminal	15.5	—	—	mm
		Terminal to Baseplate	11.3	—	—	mm
Weight	m		—	690	—	Grams
Flatness of Baseplate	e_c	On Centerline X, Y ^{*8}	± 0	—	+100	μm

Recommended Operating Conditions, $T_a = 25^\circ\text{C}$

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
DC Supply Voltage	V_{CC}	Applied Across C1-E2 Terminals	—	1000	1200	Volts
Gate-Emitter Drive Voltage	$V_{GE(on)}$	Applied Across G1-Es1/G2-Es2 Terminals	13.5	15.0	16.5	Volts
		Applied Across G1-Es1/G2-Es2 Terminals	13.5	15.0	16.5	Volts
External Gate Resistance	R_G	Per Switch	0	—	13	Ω

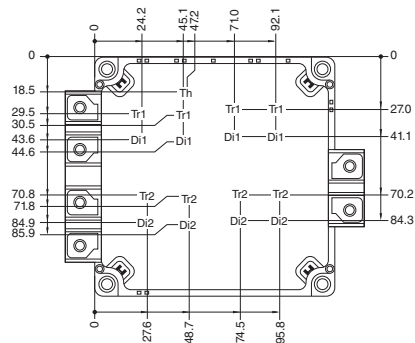
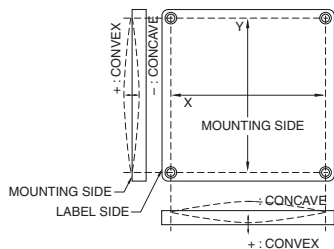
^{*4} Case temperature (T_C) and heatsink temperature (T_S) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. Refer to the figure to the right for chip location. The heatsink thermal resistance should be measured just under the chips.

^{*6} $B_{(25/50)} = \ln\left(\frac{R_{25}}{R_{50}} \cdot \frac{1}{\frac{1}{T_{25}} - \frac{1}{T_{50}}}\right)$

R_{25} ; Resistance at Absolute Temperature T_{25} [K]; $T_{25} = 25 [^\circ\text{C}] + 273.15 = 298.15$ [K]
 R_{50} ; Resistance at Absolute Temperature T_{50} [K]; $T_{50} = 50 [^\circ\text{C}] + 273.15 = 323.15$ [K]

^{*7} Typical value is measured by using thermally conductive grease of $\lambda = 0.9$ [W/(m • K)].

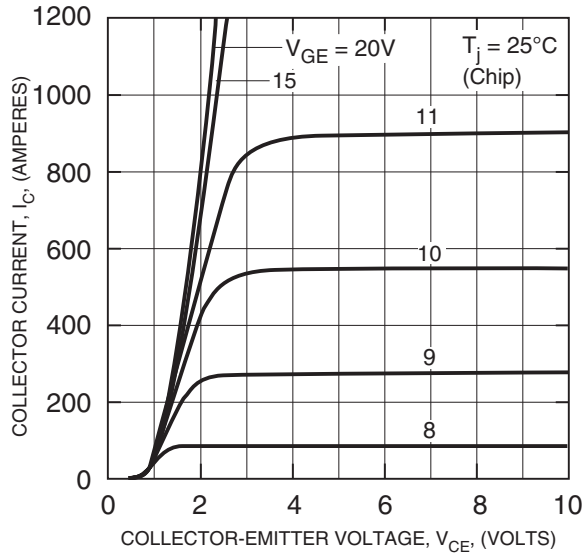
^{*8} Baseplate (mounting side) flatness measurement points (X, Y) are shown in the figure below.



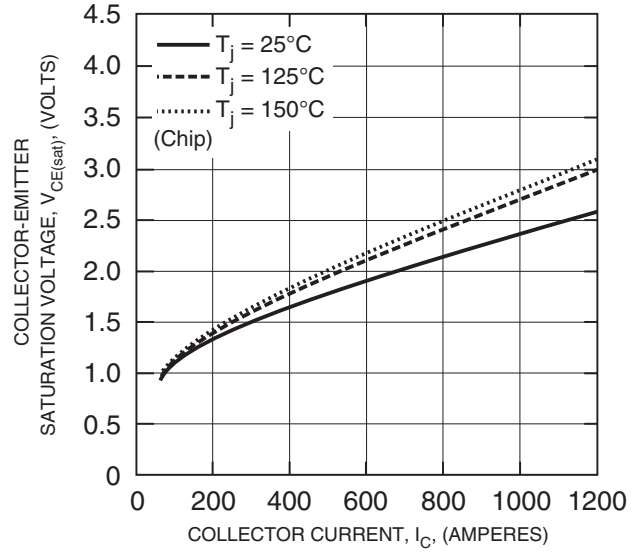
Tr1 / Tr2: IGBT, D1 / D2: FWDi, Th: NTC Thermistor
 Each mark points to the center position of each chip.

CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

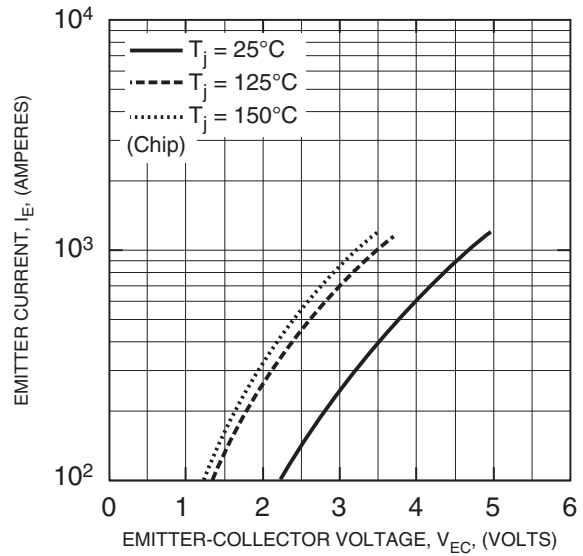
OUTPUT CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)

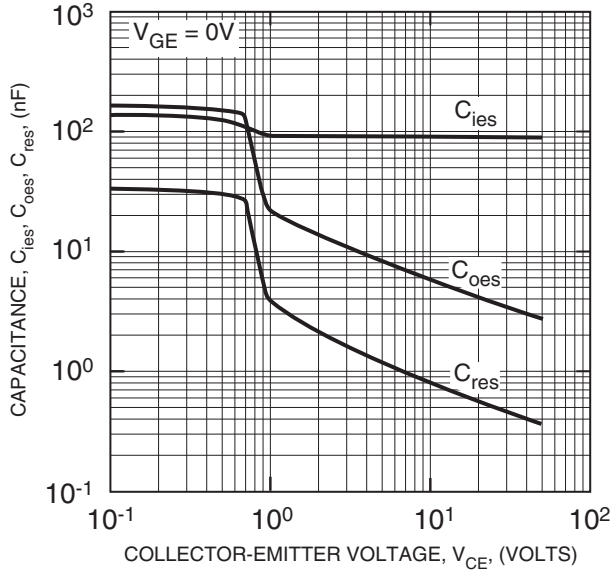


FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

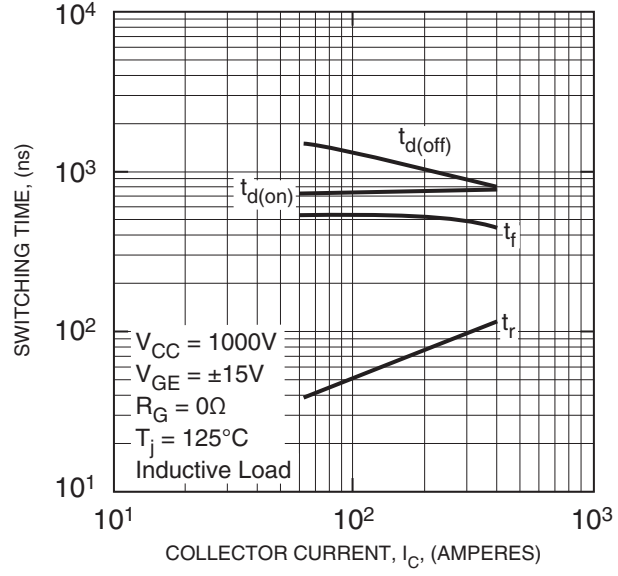


CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

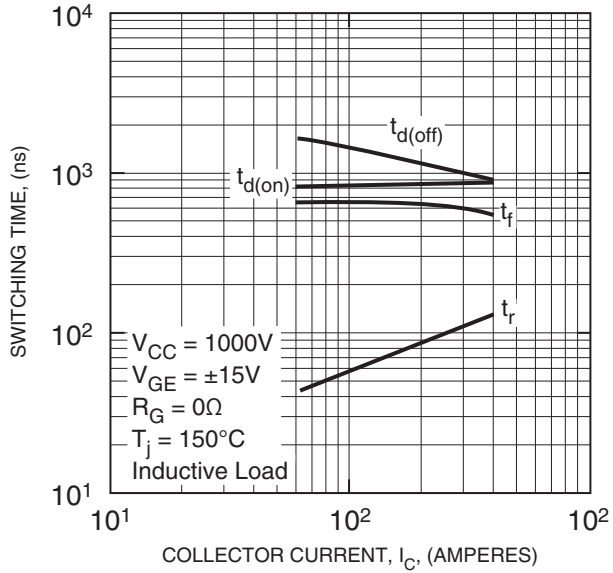
CAPACITANCE VS. V_{CE}
(TYPICAL)



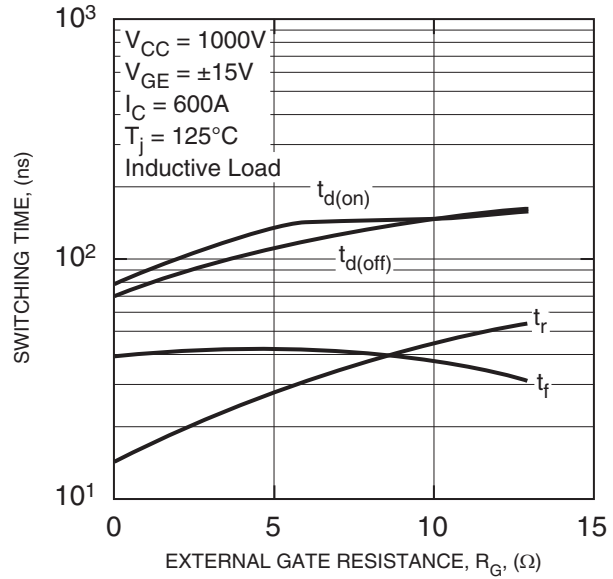
HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)



HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)

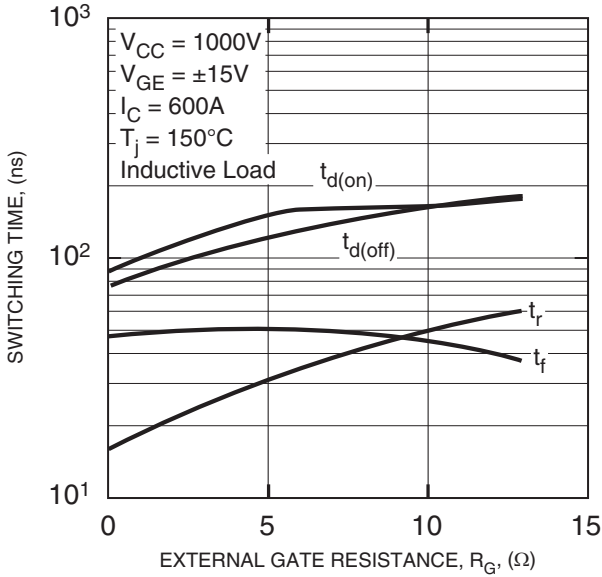


SWITCHING TIME VS.
GATE RESISTANCE
(TYPICAL)

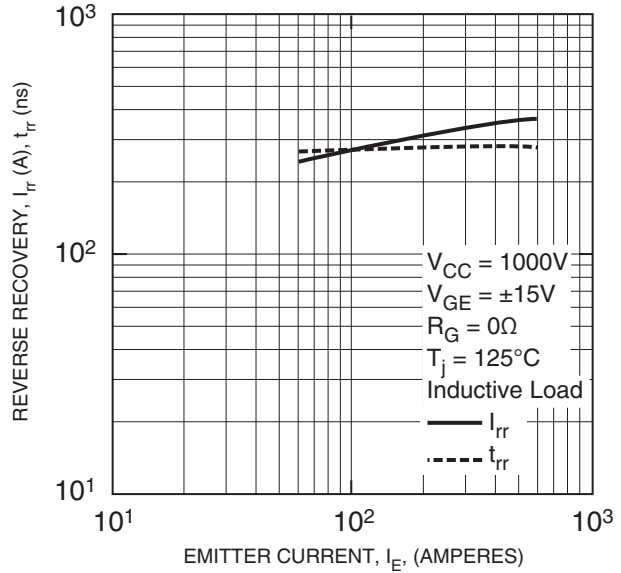


CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

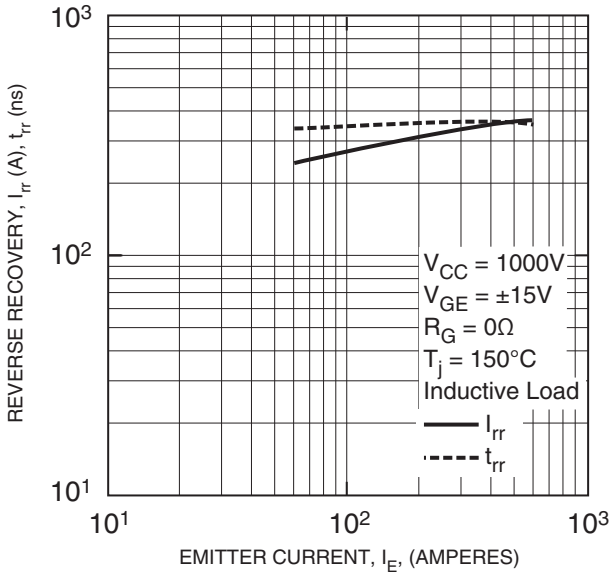
SWITCHING TIME VS. GATE RESISTANCE (TYPICAL)



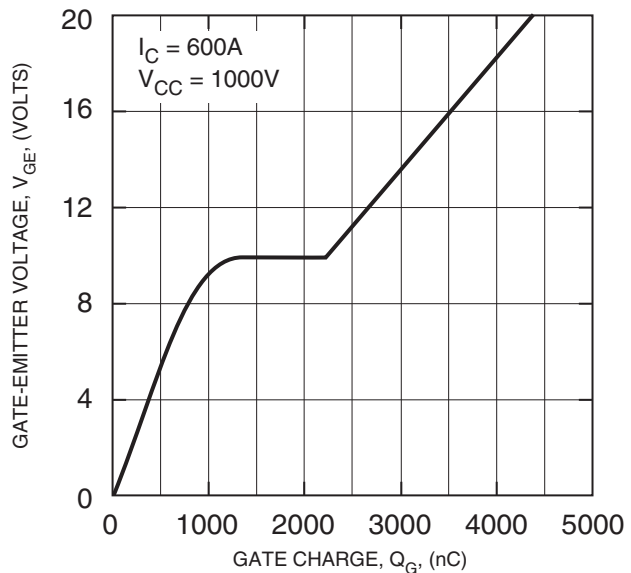
REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

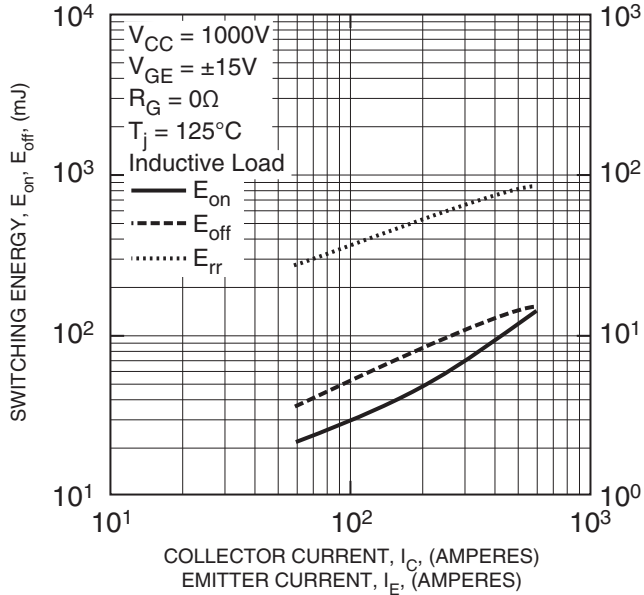


GATE CHARGE VS. V_GE (TYPICAL)

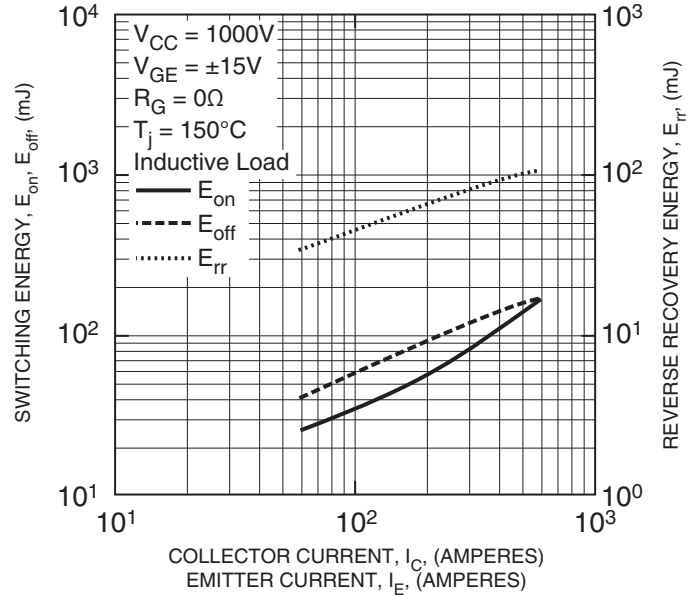


CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

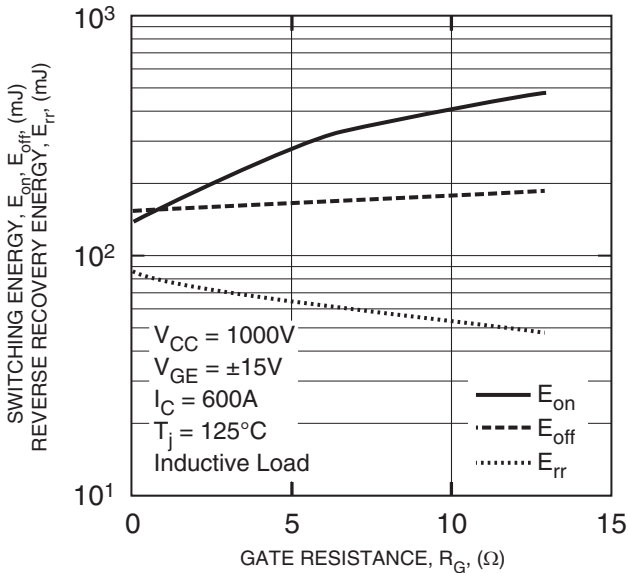
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



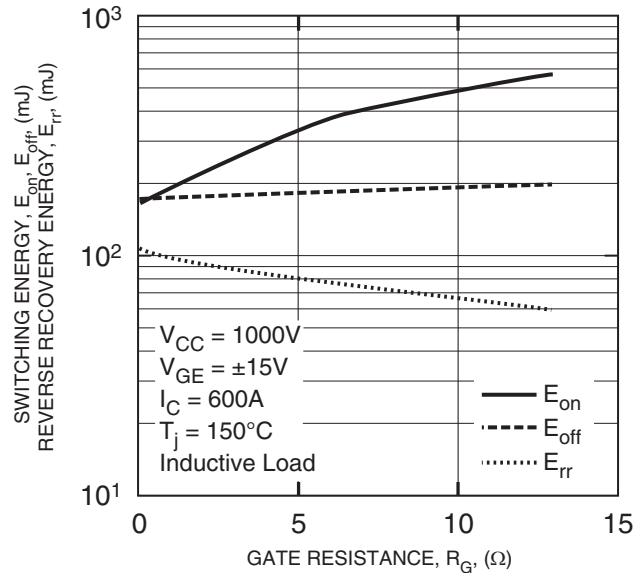
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

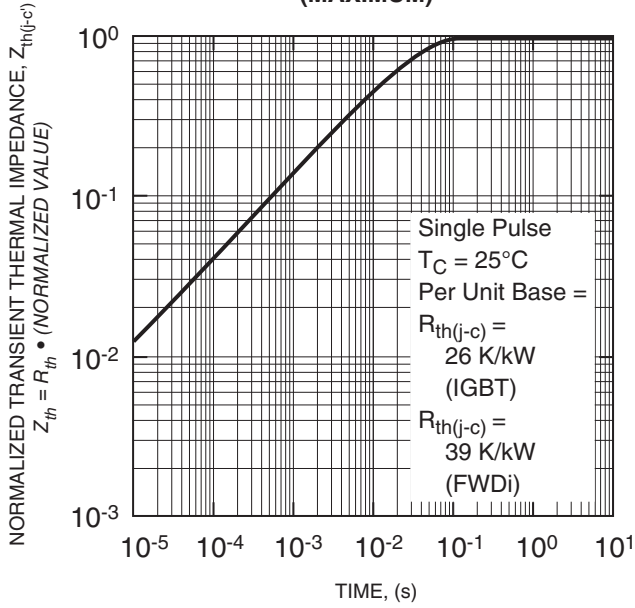


HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



CM600DXL-34SA
Dual IGBT NX-Series Module
 600 Amperes/1700 Volts

TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



TEMPERATURE CHARACTERISTICS (NTC THERMISTER PART - TYPICAL)

